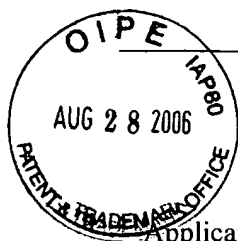


B / Ifw



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**TRANSMITTAL LETTER**  
**INFORMATION DISCLOSURE STATEMENT**

Applicant : Miles, Mark W.  
App. No : 10/082,397  
Filed : February 25, 2002  
For : VISIBLE SPECTRUM MODULATOR  
ARRAYS  
Examiner : Mai, Huy Kim  
Art Unit : 2873

**CERTIFICATE OF MAILING**

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

August 24, 2006

(Date)  
  
Mark M. Abumeri, Reg. No. 43,458

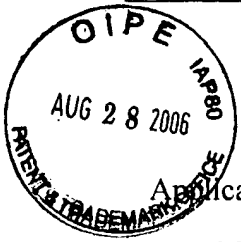
**Mail Stop Issue Fee**  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application are:

- (X) An Information Disclosure Statement and PTO/SB/08 equivalent listing references for consideration:
  - (X) Listing 230 references.
  - (X) Enclosing 32 references.
- (X) The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment, to Account No. 11-1410.
- (X) Return prepaid postcard.

Mark M. Abumeri  
Registration No. 43,458  
Attorney of Record  
Customer No. 20,995  
(619) 235-8550



## INFORMATION DISCLOSURE STATEMENT

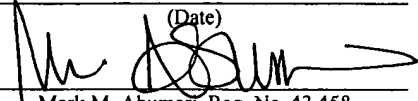
Applicant : Miles, Mark W.  
App. No : 10/082,397  
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Examiner : Mai, Huy Kim  
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Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing 230 references to be considered by the Examiner, including hard copies of 32 foreign patent references and/or non-patent literature as listed on the Information Disclosure Statement.

Please consider or place these references in the file of the above-identified patent application in accordance with 37 C.F.R. § 1.97(i).

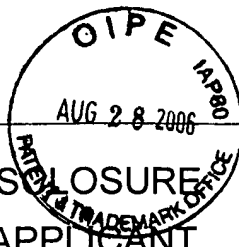
Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: August 24, 2006

By: 

Mark M. Abumeri  
Registration No. 43,458  
Attorney of Record  
Customer No. 20,995  
(619) 235-8550



# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

	Application No.	10/082,397
	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 1 OF 9	Attorney Docket No.	IRDM.025CCD

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	4,441,791	4/10/1984	Hornbeck	
	2	4,482,213	11/13/1984	Piliavin et al.	
	3	4,500,171	2/19/1985	Penz et al.	
	4	4,566,935	1/28/1986	Hornbeck	
	5	4,571,603	2/18/1986	Hornbeck et al.	
	6	4,596,992	6/24/1986	Hornbeck	
	7	4,615,595	10/7/1986	Hornbeck	
	8	4,662,746	5/5/1987	Hornbeck	
	9	4,666,254	5/19/1987	Itoh et al.	
	10	4,710,732	12/1/1987	Hornbeck	
	11	4,856,863	8/15/1989	Sampsell et al.	
	12	4,859,060	8/22/1989	Katagiri et al.	
	13	4,956,619	9/11/1990	Hornbeck	
	14	5,018,256	5/28/1991	Hornbeck	
	15	5,028,939	7/2/1991	Hornbeck et al.	
	16	5,037,173	8/6/1991	Sampsell et al.	
	17	5,061,049	10/29/1991	Hornbeck	
	18	5,079,544	1/7/1992	DeMond et al.	
	19	5,083,857	1/28/1992	Hornbeck	
	20	5,096,279	3/17/1992	Hornbeck et al.	
	21	5,099,353	3/24/1992	Hornbeck	
	22	5,142,405	8/25/1992	Hornbeck	
	23	5,162,787	11/10/1992	Thompson et al.	
	24	5,170,156	12/6/1992	DeMond et al.	
	25	5,179,274	1/12/1993	Sampsell	
	26	5,192,395	3/9/1993	Boysel et al.	
	27	5,192,946	3/9/1993	Thompson et al.	
	28	5,206,629	4/27/1993	DeMond et al.	
	29	5,214,419	5/25/1993	DeMond et al.	

Examiner Signature	Date Considered
<p><b>*Examiner:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>	

T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	Application No.	10/082,397
	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 2 OF 9	Attorney Docket No.	IRDM.025CCD

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	30	5,214,420	5/25/1993	Thompson et al.	
	31	5,216,537	6/1/1993	Hornbeck	
	32	5,226,099	7/6/1993	Mignardi et al.	
	33	5,233,385	8/3/1993	Sampsell	
	34	5,233,456	8/3/1993	Nelson	
	35	5,254,980	10/19/1993	Hendrix et al.	
	36	5,272,473	12/21/1993	Thompson et al.	
	37	5,278,652	1/11/1994	Urbanus et al.	
	38	5,280,277	1/18/1994	Hornbeck	
	39	5,287,096	2/15/1994	Thompson et al.	
	40	5,296,950	3/22/1994	Lin et al.	
	41	5,305,640	4/26/1994	Boysel et al.	
	42	5,312,513	5/17/1994	Florence et al.	
	43	5,323,002	6/21/1994	Sampsell et al.	
	44	5,325,116	6/28/1994	Sampsell	
	45	5,327,286	7/5/1994	Sampsell et al.	
	46	5,331,454	7/19/1994	Hornbeck	
	47	5,339,116	8/16/1994	Urbanus et al.	
	48	5,365,283	11/15/1994	Doherty et al.	
	49	5,411,769	5/2/1995	Hornbeck	
	50	5,444,566	8/22/1995	Gale et al.	
	51	5,446,479	8/29/1995	Thompson et al.	
	52	5,448,314	9/5/1995	Heimbuch et al.	
	53	5,452,024	9/19/1995	Sampsell	
	54	5,454,906	10/3/1995	Baker et al.	
	55	5,457,493	10/10/1995	Leddy et al.	
	56	5,457,566	10/10/1995	Sampsell et al.	
	57	5,459,602	10/17/1995	Sampsell	
	58	5,461,411	10/24/1995	Florence et al.	

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<b>*Examiner:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(Multiple sheets used when necessary)</i>	Application No.	10/082,397
	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
	Examiner	Mai, Huy Kim
SHEET 3 OF 9	Attorney Docket No.	IRDM.025CCD

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	59	5,489,952	2/6/1996	Gove et al.	
	60	5,497,197	3/5/1996	Gove et al.	
	61	5,499,062	3/12/1996	Urbanus	
	62	5,506,597	4/9/1996	Thompson et al.	
	63	5,515,076	5/7/1996	Thompson et al.	
	64	5,517,347	5/14/1996	Sampsell	
	65	5,523,803	6/4/1996	Urbanus et al.	
	66	5,526,051	6/11/1996	Gove et al.	
	67	5,526,172	6/11/1996	Kanack	
	68	5,526,688	6/18/1996	Boysel et al.	
	69	5,535,047	7/9/1996	Hornbeck	
	70	5,548,301	8/20/1996	Kornher et al.	
	71	5,551,293	9/3/1996	Boysel et al.	
	72	5,552,924	9/3/1996	Tregilgas	
	73	5,563,398	10/8/1996	Sampsell	
	74	5,567,334	10/22/1996	Baker et al.	
	75	5,570,135	10/29/1996	Gove et al.	
	76	5,581,272	12/3/1996	Conner et al.	
	77	5,583,688	12/10/1996	Hornbeck	
	78	5,589,852	12/31/1996	Thompson et al.	
	79	5,597,736	1/28/1997	Sampsell	
	80	5,600,383	2/4/1997	Hornbeck	
	81	5,602,671	2/11/1997	Hornbeck	
	82	5,606,441	2/25/1997	Florence et al.	
	83	5,608,468	3/4/1997	Gove et al.	
	84	5,610,438	3/11/1997	Wallace et al.	
	85	5,610,624	3/11/1997	Bhuva	
	86	5,610,625	3/11/1997	Sampsell	
	87	5,614,937	3/25/1997	Nelson	

Examiner Signature	Date Considered
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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	Application No.	10/082,397
	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 4 OF 9	Attorney Docket No.	IRDM.025CCD

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	88	5,619,365	4/8/1997	Rhoades et al.	
	89	5,619,366	4/8/1997	Rhoads et al.	
	90	5,646,768	7/8/1997	Kaeiyama	
	91	5,650,881	7/22/1997	Hornbeck	
	92	5,654,741	8/5/1997	Sampsell et al.	
	93	5,657,099	8/12/1997	Doherty et al.	
	94	5,659,374	8/19/1997	Gale, Jr. et al.	
	95	5,665,997	9/9/1997	Weaver et al.	
	96	5,740,150	4/4/1998	Uchimarui et al.	
	97	5,745,193	4/28/1998	Urbanus et al.	
	98	5,745,281	4/28/1998	Yi et al.	
	99	5,751,469	5/12/1998	Arney et al.	
	100	5,771,116	6/23/1998	Miller et al.	
	101	5,784,212	7/21/1998	Hornbeck	
	102	5,786,927	7/28/1998	Greywall et al.	
	103	5,808,781	9/15/1998	Arney et al.	
	104	5,818,095	10/6/1998	Sampsell	
	105	5,838,484	11/17/1998	Goossen et al.	
	106	5,842,088	11/24/1998	Thompson	
	107	5,912,758	6/15/1999	Knipe et al.	
	108	5,994,174	11/30/1999	Carey et al.	
	109	6,028,690	2/22/2000	Carter et al.	
	110	6,038,056	3/14/2000	Florence et al.	
	111	6,049,317	4/11/2000	Thompson et al.	
	112	6,056,406	5/2/2000	Park et al.	
	113	6,061,075	5/9/2000	Nelson et al.	
	114	6,097,145	8/1/2000	Kastalsky et al.	
	115	6,099,132	8/8/2000	Kaeriyama	
	116	6,113,239	9/5/2000	Sampsell et al.	

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<b>*Examiner:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	Application No.	10/082,397
	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 5 OF 9	Attorney Docket No.	IRDM.025CCD

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	117	6,147,790	11/14/2000	Meier et al.	
	118	6,160,833	12/12/2000	Floyd et al.	
	119	6,171,945	1/9/2001	Mandal et al.	
	120	6,172,797	1/9/2001	Huibers	
	121	6,180,428	1/30/2001	Peeters et al.	
	122	6,195,196	2/27/2001	Koichi et al.	
	123	6,201,633	3/13/2001	Peeters et al.	
	124	6,215,221	4/10/2001	Cabuz et al.	
	125	6,232,936	5/15/2001	Gove et al.	
	126	6,282,010	8/28/2001	Sulzbach et al.	
	127	6,288,472	9/11/2001	Cabuz et al.	
	128	6,288,824	9/11/2001	Kastalsky	
	129	6,295,154	9/25/2001	Laor et al.	
	130	6,323,982	11/27/2001	Hornbeck	
	131	6,331,909	12/18/2001	Dunfield	
	132	6,356,254	3/12/2002	Kimura	
	133	6,358,021	3/19/2002	Cabuz	
	134	6,376,787	4/23/2002	Martin et al.	
	135	6,407,851	6/18/2002	Islam et al.	
	136	6,433,917 B1	8/1/2002	Mei et al.	
	137	6,447,126	9/10/2002	Hornbeck	
	138	6,456,420	9/24/2002	Goodwin-Johansson	
	139	6,465,355	10/15/2002	Horsley	
	140	6,466,190	10/15/2002	Evoy	
	141	6,466,354	10/15/2002	Gudeman	
	142	6,466,358	10/15/2002	Tew	
	143	6,473,072	10/29/2002	Comiskey et al.	
	144	6,473,274	10/29/2002	Maimone et al.	
	145	6,480,177	11/12/2002	Doherty et al.	

Examiner Signature	Date Considered
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	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 6 OF 9	Attorney Docket No.	IRDM.025CCD

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	146	6,496,122	12/17/2002	Sampsell	
	147	6,545,335	4/8/2003	Chua et al.	
	148	6,548,908	4/15/2003	Chua et al.	
	149	6,549,338	4/15/2003	Wolverton et al.	
	150	6,552,840	4/22/2003	Knipe	
	151	6,589,625	7/8/2003	Kothari et al.	
	152	6,600,201	7/29/2003	Hartwell et al.	
	153	6,606,175	8/12/2003	Sampsell et al.	
	154	6,608,268	8/19/2003	Goldsmith	
	155	6,625,047	9/23/2003	Coleman, Jr., deceased	
	156	6,630,786	10/7/2003	Cummings et al.	
	157	6,632,698	10/14/2003	Ives	
	158	6,635,919	10/21/2003	Melendez et al.	
	159	6,643,069	11/4/2003	Dewald	
	160	6,650,455	11/18/2003	Miles, Mark W.	
	161	6,657,832	12/2/2003	Williams et al.	
	162	6,660,656	12/9/2003	Cheung et al.	
	163	6,674,090	1/6/2004	Chua et al.	
	164	6,680,792	1/20/2004	Miles	
	165	6,710,908	3/23/2004	Miles et al.	
	166	6,741,383	5/25/2004	Huibers et al.	
	167	6,775,174	8/10/2004	Huffman et al.	
	168	6,778,155	8/17/2004	Doherty et al.	
	169	6,794,119	9/21/2004	Miles	
	170	6,822,628	11/23/2004	Dunphy et al.	
	171	6,853,129	2/8/2005	Cummings et al.	
	172	6,859,218	2/22/2005	Luman et al.	
	173	6,862,022	3/1/2005	Slupe	
	174	6,862,029	3/1/2005	D'Souza et al.	

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	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 7 OF 9	Attorney Docket No.	IRDM.025CCD

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	175	6,867,896	3/15/2005	Miles	
	176	6,870,581	3/22/2005	Li et al.	
	177	2001/0003487	6/14/2001	Miles	
	178	2001/0028503	10/22/2001	Flanders et al.	
	179	2002/0015215	2/7/2002	Miles	
	180	2002/0021485	2/21/2002	Pilosof	
	181	2002/0024711	2/28/2002	Miles	
	182	2002/0054424	5/9/2002	Miles	
	183	2002/0075555	6/20/2002	Miles	
	184	2002/114558	8/22/2002	Nemirovsky	
	185	2002/0126364	9/12/2002	Miles	
	186	2002/139981	10/3/2002	Young Nigel D.	
	187	2002/0149828	10/17/2002	Miles	
	188	2002/0149850	10/17/2002	Heffner et al.	
	189	2002/0167730	11/14/2002	Needham et al.	
	190	2003/0015936	1/23/2003	Yoon et al.	
	191	2002/014579	2/7/2002	Dunfield	
	192	2003/0029705	2/13/2003	Qui et al.	
	193	2003/0016428	1/23/2003	Kato et al.	
	194	2003/0053078	3/20/2003	Missey et al.	
	195	2003/0156315	8/21/2003	Li et al.	
	196	2003/0210851	11/13/2003	Fu et al.	
	197	2004/0027701	2/12/2004	Ishikawa	
	198	2004/0056742	3/25/2004	Dabbaj	

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>

Examiner Signature	Date Considered
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	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 8 OF 9	Attorney Docket No.	IRDM.025CCD

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
	199	DE 4108966 A1	9/24/1992	IOT Entwicklungsgesellschaft für Integrierte Optik- Technologie mbH		
	200	EP 0 310 176 A2	4/5/1989	Philips Electronic and Associated Industries Limited		
	201	EP 0 788 005	8/6/1997	Arney et al.		
	202	FR 2 824 643 A	11/15/2002	Lazzari Jean Pierre		
	203	JP 62 082454	4/15/1987	CANON INC.		
	204	JP 11211999	8/6/1999	Teijin Ltd.		Abstract Only
	205	WO 02/079853	10/10/2002	Corning Intellisense Corp.		
	206	WO 03/014789 A2	2/20/2003	International Business Machines Corp.		
	207	WO 03/054925	7/3/2003	Chang-Chien et al.		
	208	WO 2005/006364 A1	1/20/2005	Commissariat a L'Energie Atomique		
	209	WO 2006/014929	2/9/2006	IDC, LLC.		

NON PATENT LITERATURE DOCUMENTS			
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Examiner Signature	Date Considered
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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	Application No.	10/082,397
	Filing Date	February 25, 2002
	First Named Inventor	Miles, Mark W.
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Mai, Huy Kim
SHEET 9 OF 9	Attorney Docket No.	IRDM.025CCD

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